


<b>Search Notes</b>  	<b>Application/Control No.</b>  10564101	<b>Applicant(s)/Patent Under Reexamination</b>  THALACKER ET AL.
	<b>Examiner</b>  Tae H Yoon	<b>Art Unit</b>  1796

SEARCHED			
Class	Subclass	Date	Examiner
523	116, 118	6/2/08	/TY/
ATD		8/26/09	/TY/

SEARCH NOTES		
Search Notes	Date	Examiner
EAST, Inventor search	5/28/08	/TY/
EAST	12/18/08	/TY/
EAST	11/18/09	/TY/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
523	116	1/4/09	/TY/
23	116	11/18/09	/TY/

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